



12V P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(ON)} max	I _D max T _A = +25°C
	15.3mΩ @ $V_{GS} = -4.5V$	-9.5A
-12V	$19m\Omega$ @ $V_{GS} = -2.5V$	-8.5A
	26.5mΩ @ V_{GS} = -1.8 V	-7.2A
	$32m\Omega$ @ $V_{GS} = -1.5V$	-6.6A

Description

This MOSFET has been designed specifically for use in battery management applications.

Features

- 0.6mm profile ideal for low profile applications
- PCB footprint of 4mm²
- Low Gate Threshold Voltage
- Fast Switching Speed
- **ESD Protected Gate**
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

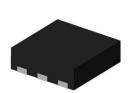
- Case: U-DFN2020-6
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper leadframe. Solderable per MIL-STD-202, Method 208 @4

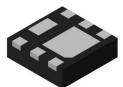
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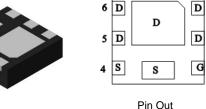
Weight: 0.0065 grams (approximate)

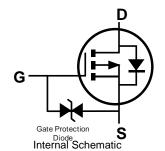
Bottom View











Top View

Bottom View

Ordering Information (Note 4)

Part Number	Marking	Reel Size (inches)	Quantity per Reel
DMP1022UFDF-7	PU	7	3,000
DMP1022UFDF-13	PU	13	10,000

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

U-DFN2020-6

Marking Information



PU = Product Type Marking Code YM = Date Code Marking Y = Year (ex: A = 2013)M = Month (ex: 9 = September)

Date Code Key

Year	201	1	2012		2013	20	14	2015		2016	2	2017
Code	Y		Z		Α	[3	С		D		Е
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units		
Drain-Source Voltage	V_{DSS}	-12	V		
Gate-Source Voltage	V_{GSS}	±8	V		
Steady State		$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	-9.5 -7.6	А
Continuous Drain Current (Note 6) V _{GS} = -4.5V	t<5s	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	Ι _D	-11.0 -8.8	А
Pulsed Drain Current (10µs pulse, duty cycle = 1%)	I _{DM}	-90	Α		
Continuous Source-Drain Diode Current	$T_A = +25$ °C $T_C = +25$ °C	Is	-2.5 -7.1	А	
Pulsed Source-Drain Diode Current (10µs pulse, duty	I _{SM}	-50	Α		

Thermal Characteristics

Characteristic	Symbol	Value	Units		
Total Dawar Dissipation (Note 5)	$T_A = +25^{\circ}C$	р	0.73	W	
Total Power Dissipation (Note 5)	$T_A = +70^{\circ}C$	P_{D}	0.47		
Thermal Resistance, Junction to Ambient (Note 5)	Steady state	D	172	°C/W	
Thermal Resistance, Junction to Ambient (Note 5)	t<5s	$R_{\theta JA}$	128	C/VV	
Total Power Dissipation (Note 6)	$T_A = +25^{\circ}C$	р	2.1	W	
Total Power Dissipation (Note 6)	$T_A = +70^{\circ}C$	P_{D}	1.3		
Thermal Resistance, Junction to Ambient (Note 6)	Steady state	D	59	°C/W	
Thermal Resistance, Junction to Ambient (Note 6)	t<5s	$R_{\theta JA}$	45		
Thermal Resistance, Junction to Case (Note 6)	Steady state	$R_{ heta JC}$	5.1		
Operating and Storage Temperature Range		T _{J,} T _{STG}	-55 to +150	°C	

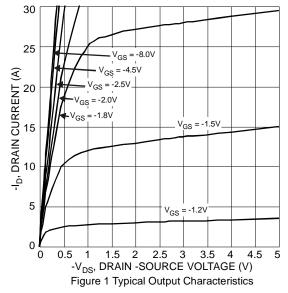
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

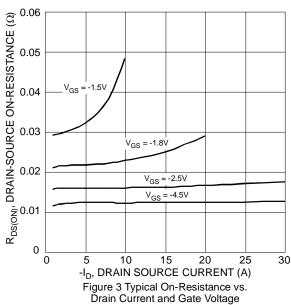
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)				•	•	•	
Drain-Source Breakdown Voltage	BV _{DSS}	-12	_	_	V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}	_	_	-1	μΑ	$V_{DS} = -12V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	_	_	±10	μA	$V_{GS} = \pm 8V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)						•	
Gate Threshold Voltage	$V_{GS(th)}$	-0.35	_	-0.8	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
			12	15.3		$V_{GS} = -4.5V, I_{D} = -4A$	
Statia Drain Sauras On Desigtanes	_		15	19	mΩ	$V_{GS} = -2.5V, I_D = -4A$	
Static Drain-Source On-Resistance	R _{DS(ON)}	_	20	26.5	11177	$V_{GS} = -1.8V, I_D = -4A$	
			23	32		$V_{GS} = -1.5V, I_D = -2A$	
Diode Forward Voltage	V _{SD}	_	-0.8	-1.2	V	$V_{GS} = 0V, I_{S} = -8A$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	C _{iss}	l	2712	_	pF		
Output Capacitance	Coss	_	514	_		$V_{DS} = -10V, V_{GS} = 0V,$ f = 1.0MHz	
Reverse Transfer Capacitance	C _{rss}	_	467	_		1 = 1.01/11 12	
Gate Resistance	Rg	_	8.6	18	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge	Qg	_	48.3	_		$V_{GS} = -8V, V_{DS} = -6V, I_{D} = -10A$	
Total Gate Charge	Qq	_	28.6	_		151/11/	
Gate-Source Charge	Q _{qs}	_	4.2	_	nC	$V_{GS} = -4.5V, V_{DS} = -6V,$	
Gate-Drain Charge	Q _{gd}	_	7.0	_		$I_D = -10A$	
Turn-On Delay Time	t _{D(on)}	_	25.1	_			
Turn-On Rise Time	t _r	-	39.8	_	1	$V_{DS} = -6V, V_{GS} = -4.5V,$	
Turn-Off Delay Time	t _{D(off)}	-	141	_	ns	$R_G = 1\Omega$, $I_D = -8A$	
Turn-Off Fall Time	t _f	_	147	_			

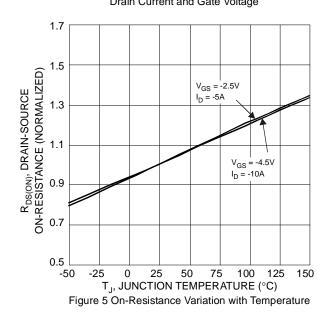
Notes:

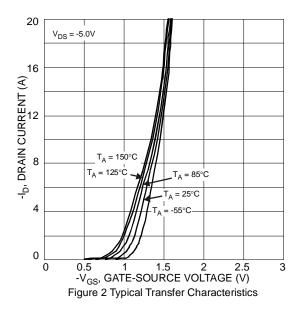
- 5. Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.
- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal vias to bottom layer 1inch square copper plate 7. Short duration pulse test used to minimize self-heating effect
- 8. Guaranteed by design. Not subject to production testing

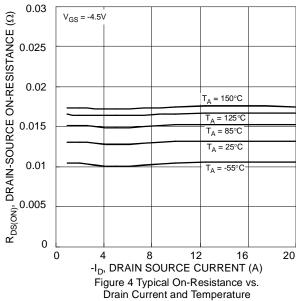












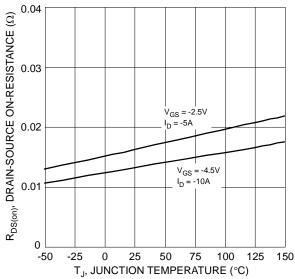


Figure 6 On-Resistance Variation with Temperature

1.2



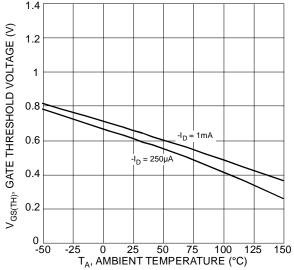
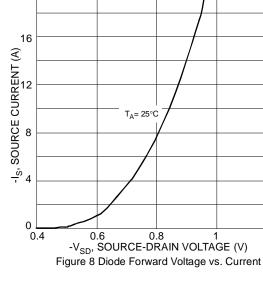
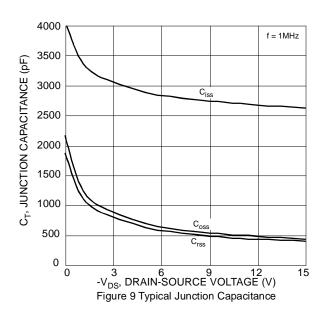
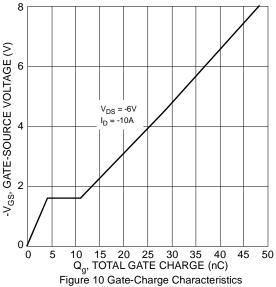


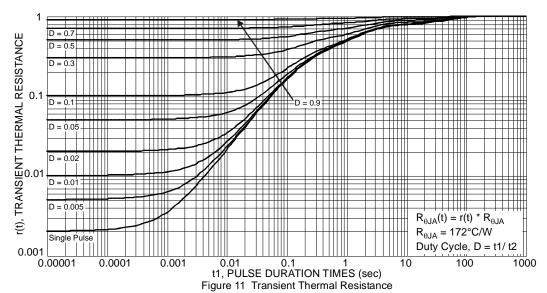
Figure 7 Gate Threshold Variation vs. Ambient Temperature



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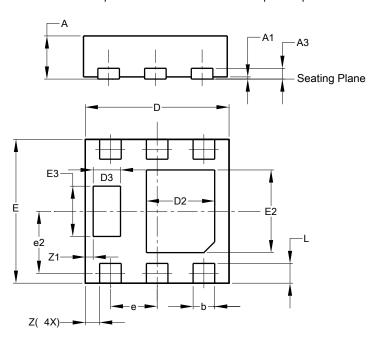






Package Outline Dimensions

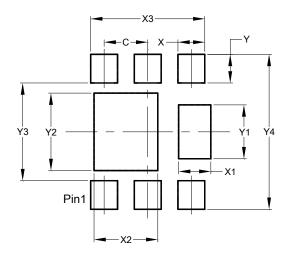
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



	U-DFN2020-6							
Dim	Min	Max	Тур					
Α	0.57	0.63	0.60					
A1	0	0.05	0.03					
A3	-	-	0.15					
b	0.25	0.35	0.30					
D	1.95	2.05	2.00					
D2	0.85	1.05	0.95					
D3	0.33	0.43	0.38					
е	0.65 BSC							
e2	C).863 B	SC					
E	1.95	2.05	2.00					
E2	1.05	1.25	1.15					
E3	0.65	0.75	0.70					
L	0.225	0.325	0.275					
Z	0.20 BSC							
Z 1	0.110 BSC							
All	All Dimensions in mm							

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for latest version.



Dimensions	Value (in mm)
С	0.650
Χ	0.400
X1	0.480
X2	0.950
Х3	1.700
Υ	0.425
Y1	0.800
Y2	1.150
Y3	1.450
Y4	2.300



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